

# Optically-Coupled Linear ISOLATION AMPLIFIERS 

## FEATURES

- BALANCED INPUT
- LARGE COMMON-MODE VOLTAGES: $\pm 2000 \mathrm{~V}$ Continuous 140dB Rejection
- ULTRA LOW LEAKAGE: $0.35 \mu \mathrm{~A}$ max at $240 \mathrm{~V} / 60 \mathrm{~Hz}$ 1.8pF Leakage Capacitance
- EXCELLENT GAIN ACCURACY: 0.05\% Linearity 0.05\%/1000 Hrs Stability
- WIDE BANDWIDTH:
$15 \mathrm{kHz} \pm 3 \mathrm{~dB}$
$1.2 \mathrm{~V} / \mathrm{\mu s}$ Slew Rate


## DESCRIPTION

The 3650 and 3652 are optically coupled integrated circuit isolation amplifiers. Prior to their introduction commercially available isolation amplifiers had been modular or rack mounted devices using transformer coupled modulation demodulation techniques. Compared to these earlier isolation amplifiers, the 3650 and 3652 have the advantage of smaller size,

## APPLICATIONS

- INDUSTRIAL PROCESS CONTROL
- dATA ACQUISITION
- INTERFACE ELEMENT
- BIOMEDICAL MEASUREMENTS
- PATIENT MONITORING
- TEST EQUIPMENT
- CURRENT SHUNT MEASUREMENT
- GROUND-LOOP ELIMINATION
- SCR CONTROLS



## SPECIFICATIONS

At $+25^{\circ} \mathrm{C}$ and $\pm 15 \mathrm{VDC}$ supply voltages, unless otherwise specified.

| PRODUCT | 3650MG, $\mathrm{HG}^{(1)}$ | 3650JG | 3650KG | 3652MG, $\mathrm{HG}^{(1)}$ | 3652JG |
| :---: | :---: | :---: | :---: | :---: | :---: |
| ISOLATION |  |  |  |  |  |
| Isolation Voltage <br> Rated Continuous, min <br> Tested Voltage, min, 10s Duration | $\begin{aligned} & 2000 \mathrm{Vp} \text { or VDC } \\ & 5000 \mathrm{Vp} \end{aligned}$ |  |  |  |  |
| Isolation Mode Rejection, $\mathrm{G}=10$ <br> DC <br> $60 \mathrm{~Hz}, 5000 \Omega$ Source Unbalance <br> Leakage Current, 240V/60Hz <br> Isolation Impedance <br> Capacitance <br> Resistance |  |  | $\begin{gathered} 140 \mathrm{~dB} \\ 120 \mathrm{~dB} \\ 0.35 \mu \mathrm{~A}, \max \\ \\ 1.8 \mathrm{pF} \\ 10^{12} \Omega \end{gathered}$ |  |  |
| GAIN |  |  |  |  |  |
| Gain Equation for Current Sources for Voltage Sources | $\mathrm{G}_{\mathrm{V} 1} 1=\frac{\mathrm{G}_{1}=10^{6} \mathrm{~V} / \mathrm{Amp}}{\mathrm{R}_{\mathrm{G} 1}+\mathrm{R}_{\mathrm{G} 2}+\mathrm{R}_{\mathrm{IN}}} \mathrm{~V} / \mathrm{V}$ |  |  | $\begin{aligned} & \mathrm{G}_{1}=1.0057 \times 10^{6} \mathrm{~V} / \mathrm{Amp}^{(2)} \\ & \frac{10^{6}}{\mathrm{R}_{\mathrm{G} 1}+\mathrm{R}_{\mathrm{G} 2}+\mathrm{R}_{\mathrm{IN}}+\mathrm{R}_{\mathrm{o}}} \mathrm{~V} / \mathrm{V} \end{aligned}$ |  |
| Input Resistance, $\mathrm{R}_{\mathrm{IN}}$, max Buffer Output Impedance, $\mathrm{R}_{\mathrm{O}}$ <br> Gain Equation Error, max ${ }^{(3)}$ <br> Gain Nonlinearity <br> Gain vs Temperature <br> Gain vs Time | $$ |  |  | $\begin{gathered} 1.5 \%(4) \\ \pm 0.05 \% \text { typ } \pm 0.2 \% \text { max } \\ 300 \mathrm{ppm} /{ }^{\circ} \mathrm{C} \\ \pm 0.05 \% \end{gathered}$ | $\begin{aligned} & \pm 30 \Omega \\ & \quad 0.5 \%(4) \\ & \pm 0.05 \% \text { typ } \pm 0.1 \% \text { max } \\ & 200 \mathrm{ppm} /{ }^{\circ} \mathrm{C} \\ & 1000 \mathrm{hrs} \end{aligned}$ |
| Frequency Response <br> Slew Rate $\pm 3 \mathrm{~dB}$ Frequency Settling Time to $\pm 0.01 \%$ to $\pm 0.1 \%$ | $\begin{gathered} 0.7 \mathrm{~V} / \mu \mathrm{s} \min , 1.2 \mathrm{~V} / \mu \mathrm{s} \text { typ } \\ 15 \mathrm{kHz} \\ \\ 400 \mu \mathrm{~s} \\ 200 \mu \mathrm{~s} \end{gathered}$ |  |  |  |  |
| INPUT STAGE ${ }^{(5)}$ |  |  |  |  |  |
| $\begin{aligned} & \text { Input Offset Voltage } \\ & \text { at } 25^{\circ} \mathrm{C} \text {, max } \\ & \text { vs Temperature, max } \\ & \text { vs Supply } \\ & \text { vs Time } \end{aligned}$ | $\begin{gathered} \pm 5 \mathrm{mV} \\ \pm 25 \mu \mathrm{~V} /{ }^{\circ} \mathrm{C} \end{gathered}$ | $\begin{gathered} \pm 1 \mathrm{mV} \\ \pm 10 \mu \mathrm{~V} /{ }^{\circ} \mathrm{C} \\ 100 \mu \mathrm{~V} / \mathrm{V} \\ 50 \mu \mathrm{~V} / 1000 \mathrm{hrs} \end{gathered}$ | $\begin{gathered} \pm 0.5 \mathrm{mV} \\ \pm 5 \mu \mathrm{~V} /{ }^{\circ} \mathrm{C} \end{gathered}$ | $\begin{aligned} & \pm 5 \mathrm{mV} \\ & \pm 50 \mu \mathrm{~V} /{ }^{\circ} \mathrm{C} \\ & \\ & \\ & \\ & \\ & \\ & 100 \mu \mathrm{~V} \end{aligned}$ | $\begin{gathered} \pm 2 \mathrm{mV} \\ \pm 25 \mu \mathrm{~V} /{ }^{\circ} \mathrm{C} \end{gathered}$ <br> V/V 000hrs |
| Input Bias Current at $25^{\circ} \mathrm{C}$ vs Temperature vs Supply |  | 10nA typ, 40nA max $0.3 \mathrm{nA} /{ }^{\circ} \mathrm{C}$ <br> $0.2 \mathrm{nA} / \mathrm{V}$ |  | 10pA ty <br> Doubles | 50pA max <br> very $+10^{\circ} \mathrm{C}$ <br> A/V |
| Input Offset Current vs Temperature vs Supply |  | Effects Included <br> In Output Offset |  | Doubles |  |
| Input Impedance Differential Common-Mode |  | $\begin{gathered} " \mathrm{R}_{\mathrm{IN}} "=25 \Omega \text { max } \\ 10^{9} \Omega \end{gathered}$ |  |  |  |
| Input Noise Voltage, 0.05 Hz to 100 Hz 10 Hz to 10 kHz |  | $4 \mu \mathrm{Vp}-\mathrm{p}$ $4 \mu \mathrm{Vrms}$ |  |  |  |
| ```Input Voltage Range Common-Mode, Linear Operation, w/o damage, at +, - at +l, -I at +I I},-\mp@subsup{l}{R}{``` |  | $\begin{gathered} \pm(\|\mathrm{V}\|-5) \mathrm{V} \\ \pm \mathrm{V} \end{gathered}$ <br> Not Applicable ${ }^{(6)}$ Not Applicable ${ }^{(6)}$ |  | $\begin{array}{r} \quad \pm(\\| \\ \pm 300 \mathrm{~V} \\ \pm 3000 \mathrm{~V} \end{array}$ | $\begin{aligned} & \mid-5) \\ & v \\ & \text { v } 10 \mathrm{~ms}^{(7)} \\ & \text { or } 10 \mathrm{~ms}^{(7)} \end{aligned}$ |
| Differential, w/o damage, at,+- <br> Differential, w/o damage, at $+\mathrm{l},-\mathrm{I}$ <br> Differential, w/o damage, <br> at $+I_{R}, I_{R}$ |  | $\pm \mathrm{V}$ <br> Not Applicable <br> Not Applicable |  | $\pm 600 \mathrm{~V}$ $\pm 6000 \mathrm{~V}$ | $10 \mathrm{~ms}^{(7)}$ <br> or $10 \mathrm{~ms}^{(7)}$ |
| Common-Mode Rejection, 60Hz |  | dB at $60 \mathrm{~Hz}, 5 \mathrm{k} \Omega$ Imbalan |  | 80 dB at 60 Hz | $5 \mathrm{k} \Omega$ Imbalance |
| Power Supply (Input Stage Only) <br> Voltage (at "+V" and "-V") <br> Current <br> Quiescent with $\pm 10 \mathrm{~V}$ Output ${ }^{(7)}$ |  | $\begin{gathered} \pm 8 \mathrm{~V} \text { to } \pm 18 \mathrm{~V} \\ \pm 1.2 \mathrm{~mA}^{(8)} \\ +6.5 \mathrm{~mA} \text { or }-6.5 \mathrm{~mA}, \text { typ } \\ +12 \mathrm{~mA} \text { or }-12 \mathrm{~mA}, \max \end{gathered}$ |  | $\begin{array}{r}  \pm 8 \mathrm{~V} \\ \pm 3 \\ +8.5 \mathrm{~mA} \text { or } \\ +16 \mathrm{~mA}, \text { or } \end{array}$ | $\begin{aligned} & \pm 18 \mathrm{~V} \\ & \mathrm{AA}^{(8)} \\ & -8.5 \mathrm{~mA}, \text { typ } \\ & -16 \mathrm{~mA}, \max \end{aligned}$ |

## SPECIFICATIONS (CONT)

At $+25^{\circ} \mathrm{C}$ and $\pm 15$ VDC supply voltages, unless otherwise specified.

| PRODUCT | 3650MG, HG ${ }^{(1)}$ | 3650JG | 3650KG | 3652MG, $\mathrm{HG}^{(1)}$ | 3652JG |
| :---: | :---: | :---: | :---: | :---: | :---: |
| OUTPUT STAGE |  |  |  |  |  |
| Output Voltage, min Output Current, min Output Offset Voltage at $25^{\circ} \mathrm{C}, \max ^{(3)}$ vs Temperature, max vs Supply vs Time | $\begin{gathered} \pm 25 \mathrm{mV} \\ \pm 900 \mu \mathrm{~V} /{ }^{\circ} \mathrm{C} \end{gathered}$ | $\pm 10 \mathrm{~V}$ $\pm 5 \mathrm{~mA}$ $\pm 10 \mathrm{mV}$ $\pm 450 \mu \mathrm{~V} /{ }^{\circ} \mathrm{C}$ $\pm 500 \mu \mathrm{~V} / \mathrm{V}$ $\pm 1 \mathrm{mV} / 1000 \mathrm{hrs}$ | $\begin{gathered} \pm 10 \mathrm{mV} \\ \pm 300 \mu \mathrm{~V} /{ }^{\circ} \mathrm{C} \end{gathered}$ | $$ |  |
| $\begin{aligned} & \text { Output Noise Voltage } \\ & 0.05 \mathrm{~Hz} \text { to } 100 \mathrm{~Hz} \\ & 10 \mathrm{~Hz} \text { to } 1 \mathrm{kHz} \end{aligned}$ | $50 \mu \vee p-p$$65 \mu \mathrm{Vrms}$ |  |  | $50 \mu \vee p-p$$65 \mu \mathrm{Vrms}$ |  |
| Power Supply (Output Stage Only) <br> Voltage ("+ $\mathrm{V}_{\mathrm{CC}}$ " and " $-\mathrm{V}_{\mathrm{CC}}$ ") <br> Current <br> Quiescent with $\pm 5 \mathrm{~mA}$ Output, max | $\begin{gathered} \pm 8 \mathrm{~V} \text { to } \pm 18 \mathrm{~V} \\ \pm 2.3 \mathrm{~mA} \text { typ, } \pm 6 \mathrm{~mA} \max \\ \pm 11 \mathrm{~mA} \end{gathered}$ |  |  |  |  |
| TEMPERATURE ${ }^{(9)}$ |  |  |  |  |  |
| Specification Operating Storage | $0^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ <br> $-40^{\circ} \mathrm{C}$ to $+100^{\circ} \mathrm{C}$ <br> $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |  |  |  |  |

NOTES: (1) All electrical and mechanical specifications of the 3650MG and 3652MG are identical to the 3650 HG and 3652 HG , respectively, except that the following specifications apply to the 3650MG and 3652MG: (a) Isolation test voltage duration increased from 10 seconds minimum to 60 seconds minimum; (b) Input offset voltage at $25^{\circ} \mathrm{C}$, max: $\pm 10 \mathrm{mV}$; vs temperature max: $\pm 100 \mu \mathrm{~V} /{ }^{\circ} \mathrm{C}$; (c) Output offset voltage at $25^{\circ} \mathrm{C}$, max; $\pm 50 \mathrm{mV}$; vs temperature $\mathrm{max} ; \pm 1.8 \mathrm{mV} /{ }^{\circ} \mathrm{C}$. (2) If used as 3650 , see Installation and Operating Instructions. (3) Trimmable to zero. (4) Gain error terms specified for inputs applied through buffer amplifiers (i.e., $\pm 1$ or $\pm \mathrm{I}_{\mathrm{R}}$ pins). (5) Input stage specifications at +l and -I inputs for 3652 unless otherwise noted. (6) Maximum safe input current at either input is 10mA. (7) Continuous rating is $1 / 3$ pulse rating. (8) Load current is drawn from one supply lead at a time: other supply current at quiescent level. For 3652 add $0.2 \mathrm{~mA} / \mathrm{V}$ of positive CMV . (9) $\mathrm{dT} / \mathrm{dt}<1^{\circ} \mathrm{C} / \mathrm{minute}$ below $0^{\circ} \mathrm{C}$, and long-term storage above $100^{\circ} \mathrm{C}$ is not recommended. Also limit the repeated thermal cycles to be within the $0^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ temperature range.

## PIN CONFIGURATIONS



PACKAGE INFORMATION

| PRODUCT | PACKAGE | PACKAGE DRAWING <br> NUMBER |
| :--- | :---: | :---: |
| 3650 | 32-Pin DIP | 77 |
| 3652 | 32-Pin DIP | 77 |

NOTE: (1) For detailed drawing and dimension table, please see end of data sheet, or Appendix C of Burr-Brown IC Data Book.

## ELECTROSTATIC DISCHARGE SENSITIVITY

This integrated circuit can be damaged by ESD. Burr-Brown recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

[^0]
## TYPICAL PERFORMANCE CURVES

Typical at $+25^{\circ} \mathrm{C}$ and $\pm 15$ VDC power supplies, unless otherwise noted.






$$
\frac{\mathrm{R}_{\mathrm{G} 1}}{\mathrm{R}_{\mathrm{G} 1}+\mathrm{R}_{\mathrm{G} 2}} \text { or } \frac{\mathrm{R}_{\mathrm{G} 2}}{\mathrm{R}_{\mathrm{G} 1}+\mathrm{R}_{\mathrm{G} 2}}
$$



## TYPICAL PERFORMANCE CURVES (CONT)

Typical at $+25^{\circ} \mathrm{C}$ and $\pm 15$ VDC power supplies, unless otherwise noted.







## DEFINITIONS

## ISOLATION-MODE VOLTAGE, $\mathrm{V}_{\text {ISo }}$

The isolation-mode voltage is the voltage which appears across the isolation barrier, i.e., between the input common and the output common. (See Figure 1.)
Two isolation voltages are given in the electrical specifications: "rated continuous" and "test voltage". Since it is impractical on a production basis to test a "continuous" voltage (infinite test time is implied), it is a generally accepted practice to test at a significantly higher voltage for some reasonable length of time. For the 3650 and 3652, the "test voltage" is equal to 1000 V plus two times the "rated continuous" voltage. Thus, for a continuous rating of 2000 V , each unit is tested at 5000 V .

## COMMON-MODE VOLTAGE, $\mathrm{V}_{\mathrm{CM}}$

The common-mode voltage is the voltage midway between the two inputs of the amplifier measured with respect to input common. It is the algebraic average of the voltage applied at the amplifiers' input terminals. In the circuit in Figure $1,\left(\mathrm{~V}_{+}+\mathrm{V}_{-}\right) / 2=\mathrm{V}_{\mathrm{CM}}$. (NOTE: Many applications involve a large system "common-mode voltage." Usually in such cases the term defined here as " $\mathrm{V}_{\mathrm{CM}}$ " is negligible and the system "common-mode voltage" is applied to the amplifier as " $\mathrm{V}_{\text {ISO }}$ " in Figure 1.)

## ISOLATION-MODE REJECTION

The isolation-mode rejection is defined by the equation in Figure 1. The isolation-mode rejection is not infinite because there is some leakage across the isolation barrier due to the isolation resistance and capacitance.


FIGURE 1. Illustration of Isolation-Mode and CommonMode Specifications.

NOTE: (1) The only effect of decreased LED output is a slight decrease in full scale swing capability. See Typical Performance Curves.

## NONLINEARITY

Nonlinearity is specified to be the peak deviation from a best straightline expressed as a percent of peak-to-peak full scale output (i.e. $\pm 10 \mathrm{mV}$ at $20 \mathrm{Vp}-\mathrm{p} \approx 0.05 \%$ ).

## THEORY OF OPERATION

Prior to the introduction of the 3650 family optical isolation had not been practical in linear circuits. A single LED and photodiode combination, while useful in a wide range of digital isolation applications, has fundamental limitationsprimarily nonlinearity and instability as a function of time and temperature.
The 3650 and 3652 use a unique technique to overcome the limitations of the single LED and photodiode isolator. Figure 2 is an elementary equivalent circuit for the 3650 , which can be used to understand the basic operation without considering the cluttering details of offset adjustment and biasing for bipolar operation.


FIGURE 2. Simplified Equivalent Circuit of Linear Isolator.

Two matched photodiodes are used-one in the input $\left(\mathrm{CR}_{3}\right)$ and one in the output stage $\left(\mathrm{CR}_{2}\right)$-to greatly reduce nonlinearities and time-temperature instabilities. Amplifier $\mathrm{A}_{1}$, LED $\mathrm{CR}_{1}$, and photodiode $\mathrm{CR}_{3}$ are used in a negative feedback configuration such that $I_{1}=I_{I N} R_{G}$ (where $R_{G}$ is the user supplied gain setting resistor). Since $\mathrm{CR}_{2}$ and $\mathrm{CR}_{3}$ are closely matched, and since they receive equal amounts of light from the LED $\mathrm{CR}_{1}$ (i.e., $\lambda_{1}=\lambda_{2}$ ), $\mathrm{I}_{2}=\mathrm{I}_{1}=\mathrm{I}_{\mathrm{IN}}$. Amplifier $\mathrm{A}_{2}$ is connected as a current-to-voltage converter with $\mathrm{V}_{\text {OUT }}$ $=I_{2} R_{K}$ where $R_{K}$ is an internal $1 M \Omega$ scaling resistor. Thus the overall transfer function is:

$$
\mathrm{V}_{\text {OUT }}=\mathrm{V}_{\mathrm{IN}} \frac{10^{6}}{\mathrm{R}_{\mathrm{G}}},\left(\mathrm{R}_{\mathrm{G}} \text { in } \Omega \mathrm{s}\right)
$$

This improved isolator circuit overcomes the primary limitations of the single LED and photodiode combination. The transfer function is now virtually independent of any degradation in the LED output as long as the two photodiodes and optics are closely matched ${ }^{(1)}$. Linearity is now a
function of the accuracy of the matching and is further enhanced by the use of negative feedback in the input stage. Advanced laser trimming techniques are used to further compensate for residual matching errors.
A model of the 3650 suitable for simple circuit analysis is shown in Figure 3. The output is a current dependent voltage source, $\mathrm{V}_{\mathrm{D}}$, whose value depends on the input current. Thus, the 3650 is a transconductance amplifier with a gain of one volt per microamp. When voltage sources are used, the input current is derived by using gain setting resistors in series with the voltage source (see Installation and Operating Instructions for details). $\mathrm{R}_{\text {IN }}$ is the differential input impedance. The common-mode and isolation impedances are very high and are assumed to be infinite for this model.


FIGURE 3. Simple Model of 3650.
A simplified model of the 3652 is shown in Figure 4. The isolation and output stages are identical to the 3650 . Additional input circuitry consisting of FET buffer amplifiers and input protection resistors have been added to give higher differential and common-mode input impedance ( $10^{11} \Omega$ ),
lower bias currents ( 50 pA ) and overvoltage protection. The $+I_{R}$ and $-I_{R}$ inputs have a 10 ms pulse rating of 6000 V differential and 3000 V common-mode (see Definitions for a discussion of common-mode and isolation-mode voltages.) The addition of the buffer amplifiers also creates a voltagein voltage-out transfer function with the gain set by $\mathrm{R}_{\mathrm{Gl}}$ and $\mathrm{R}_{\mathrm{G} 2}$.

## INSTALLATION AND OPERATING INSTRUCTIONS

## POWER SUPPLY CONNECTIONS

The power supply connections for the 3650 and 3652 are shown in Figure 5. When a DC/DC converter is used for isolated power, it is placed in parallel with the isolation barrier of the amplifier. This can lower the isolation impedance and degrade the isolation-mode rejection of the overall circuit. Therefore, a high quality, low leakage DC/DC converter such as the Burr-Brown Model 722 should be used.

## OFFSET VOLTAGE ADJUSTMENTS

The offset nulling circuits are identical for the 3650 and 3652 and are shown in Figure 5. The offset adjust circuitry is optional and the units will meet the stated specifications with the BAL terminals unconnected. Provisions are available to null both the input and output stage offsets. If the amplifier is operated at a fixed gain, normally only one adjustment will be used: the output stage ( $10 \mathrm{k} \Omega$ adjustment) for low gains and the input stage ( $50 \mathrm{k} \Omega$ adjustment) for high gains, ( $>10$ ).
Use the following procedure if it is desired to null both input and output components. (For example, if the gain of the amplifier is to be switched). The input stage offset is first nulled ( $50 \mathrm{k} \Omega$ adjustment) with the appropriate input signal pins connected to input common and the amplifier set at its maximum gain. The gain is then set to its minimum value and the output offset is nulled ( $10 \mathrm{k} \Omega$ adjustment).


FIGURE 4. Simple Model of 3652.


FIGURE 5. Power and Offset Adjust Connections.

## INPUT CONFIGURATIONS

Some possible input configurations for the 3650 and 3652 are shown in Figures 6a, 6b, 6c. Differential input sources are used in these examples. For situations with nondifferential inputs, the appropriate source term should be set to zero in the gain equations and replaced with a short in the diagrams.
Figure 6a shows the 3650 connected as a transconductance amplifier with input current sources. Voltage sources are shown in Figure 6b. In this case the voltages are converted to currents by $\mathrm{R}_{\mathrm{G} 1}$ and $\mathrm{R}_{\mathrm{G} 2}$. As shown by the equations, they perform as gain setting resistors in the voltage transfer function. When a single voltage source is used, it is recommended (but not essential) that the gain setting resistor remain split into two equal halves in order to minimize errors due to bias currents and common-mode rejection (see Typical Performance Curves).
Figure 6c illustrates the connections for the 3652 when the FET buffer amplifiers, $\mathrm{A}_{1}$ and $\mathrm{A}_{2}$, are used. This configuration provides an isolation amplifier with high input impedance (both common-mode and differential, and good com-mon-mode and isolation-mode rejection. It is a true isolated instrumentation amplifier which has many benefits for noise rejection when source impedance imbalances are present.
In the 3652, the voltage gain of the buffer amplifiers is slightly less than unity, but the gain of the output stage has been raised to compensate for this so that the overall transfer function from the $\pm \mathrm{I}$ or $\pm \mathrm{I}_{\mathrm{R}}$ inputs to the output is correct. It should be noted that $\mathrm{A}_{1}$ and $\mathrm{A}_{2}$ are buffer amplifiers. No summing can be done at the $\pm \mathrm{I}$ or $\pm \mathrm{I}_{\mathrm{R}}$ inputs. Figure 6 c shows the +I and -I inputs used. If more input voltage protection is desired, then the $+I_{R}$ and $-I_{R}$ inputs should be used. This will increase the input noise due to the contribution from the $1.6 \mathrm{M} \Omega$ resistors, but will provide additional differential and common-mode protection ( 10 ms rating of 3 kV ).


NOTE: (1) The offset adjustment circutry and power supply connections have been omitted for simplicity. Refer to Figure 5 for details. (2) IMRR here is in $\mathrm{pA} / \mathrm{V}$, typically $5 \mathrm{pA} / \mathrm{V}$ at 60 Hz and $1 \mathrm{pA} / \mathrm{V}$ at DC .

FIGURE 6a. 3650 with Differential Current Sources.


NOTE: (1) The offset adjustment circutry and power supply connections have been omitted for simplicity. Refer to Figure 5 for details.

FIGURE 6b. 3650 with Differential Voltage Sources.

## ERROR ANALYSIS

A model of the 3650 suitable for DC error analysis of offset voltage, voltage drift versus temperature, bias current, etc., is shown in Figure 7.
$\mathrm{A}_{1}$ and $\mathrm{A}_{2}$, the input and output stage amplifiers, are considered to be ideal. Separate external generators are used to model the offset voltages and bias currents. $R_{\text {IN }}$ is assumed to be small relative to $\mathrm{R}_{\mathrm{G} 1}$ and $\mathrm{R}_{\mathrm{G} 2}$ and is therefore omitted from the gain equation. The feedback configuration, optics and component matching are such that $I_{1}=I_{2}=I_{3}=I_{4}$. A simple circuit analysis gives the following expression for the


FIGURE 6c. 3652 with Differential Voltage Sources.


FIGURE 7. DC Error Analysis Model for 3650.
total output error voltage due to offset voltages and bias currents.
$\mathrm{V}_{\text {OUT-TOTAL }}=\frac{10^{6}}{\mathrm{R}_{\mathrm{G} 1}+\mathrm{R}_{\mathrm{G} 2}}\left[\mathrm{E}_{\mathrm{OSI}}+\left(\mathrm{I}_{\mathrm{B} 1} \mathrm{R}_{\mathrm{GI}}-\mathrm{I}_{\mathrm{B} 2} \mathrm{R}_{\mathrm{G} 2}\right)\right]+\mathrm{E}_{\mathrm{OSO}}$ (1)
Offset current is defined as the difference between the two bias currents $I_{B 1}$ and $I_{B 2}$. If $I_{B 1}=I_{B}$ and $I_{B 2}=I_{B}+I_{\text {OSI }}$
then, for $\mathrm{R}_{\mathrm{G} 1}=\mathrm{R}_{\mathrm{G} 2}, \mathrm{~V}_{\mathrm{OUT}}-\mathrm{I}_{\mathrm{B}}=\frac{10^{6} \mathrm{I}_{\mathrm{OS}}}{2}$
This component of error is not a function of gain and is therefore included as a part of $\mathrm{E}_{\mathrm{OSO}}$ specifications. The output errors due to the output stage bias current are also included in $\mathrm{E}_{\mathrm{OSO}}$. This results in a very simple equation for the total error:

$$
\begin{equation*}
\mathrm{V}_{\text {OUT-TOTAL }}=\frac{10^{6} \mathrm{E}_{\mathrm{OSI}}}{2 \mathrm{R}_{\mathrm{G} 1}}+\mathrm{E}_{\mathrm{OSO}}\left(\text { for } \mathrm{R}_{\mathrm{G} 1}=\mathrm{R}_{\mathrm{G} 2}\right) \tag{2}
\end{equation*}
$$

In summary, it should be noted that equation (2) should be used only when $R_{G 1}=R_{G 2}$. When $R_{G 1} \neq R_{G 2}$, equation (1) applies.

The effects of temperature may be analyzed by replacing the offset terms with their corresponding temperature gradient terms:

$$
\mathrm{V}_{\mathrm{OUT}} \rightarrow \Delta \mathrm{~V}_{\mathrm{OUT}} / \Delta \mathrm{T}, \mathrm{E}_{\mathrm{OSI}} \rightarrow \Delta \mathrm{E}_{\mathrm{OSI}} / \Delta \mathrm{T}, \text { etc. }
$$

For a complete analysis of the effects of temperature, gain variations must also be considered.

## OUTPUT NOISE

The total output noise is given by:

$$
\mathrm{E}_{\mathrm{N}}(\mathrm{RMS})=\sqrt{\left(\mathrm{E}_{\mathrm{NI}} \mathrm{G}\right)^{2}+\left(\mathrm{E}_{\mathrm{NO}}\right)^{2}}
$$

where $E_{N}(R M S)=$ Total output noise

$$
\begin{aligned}
& \mathrm{E}_{\mathrm{NI}}=\mathrm{RMS} \text { noise of the input stage } \\
& \mathrm{E}_{\mathrm{NO}}=R M S \text { noise of the output stage } \\
& \mathrm{G}=10^{6} /\left(\mathrm{R}_{\mathrm{G} 1}+\mathrm{R}_{\mathrm{G} 2}\right)
\end{aligned}
$$

$\mathrm{E}_{\mathrm{NO}}$ includes the noise contribution due to the optics and the noise currents of the output stage. Errors created by the noise current of the input stage are insignificant compared to other noise sources and are therefore omitted.

## COMMON-MODE AND <br> ISOLATION-MODE REJECTION

The expression for the output error due to common-mode and isolation mode voltage is:

$$
\mathrm{V}_{\text {OUT }}=\mathrm{G}\left[\frac{\mathrm{~V}_{\mathrm{CM}}}{\mathrm{CMRR}}+\frac{\mathrm{V}_{\mathrm{ISO}}}{\mathrm{IMRR}}\right]
$$

## GUARDING AND PROTECTION

To preserve the excellent inherent isolation characteristics of these amplifiers, the following recommended practice should be noted.

1. Use shielded twisted pair of cable at the input as with any instrumentation amplifier.
2. Care should be taken to minimize external capacitance. A symmetrical layout of external components to achieve balanced capacitance from the input terminals to output common will preserve high IMR.
3. External components and conductor patterns should be at a distance equal to or greater than the distance between the input and output terminals to prevent HV breakdown.
4. Though not an absolute requirement, the use of laminated or conformally coated printed circuit boards is recommended.

## APPLICATIONS

Figure 8 shows a system where isolation amplifiers (3650) are used to measure the armature current and the armature voltage of a motor.
The armature current of the motor is converted to a voltage by the calibrated shunt $\mathrm{R}_{\mathrm{S}}$ and then amplifier (adjustable gain) and isolated by the 3650 .
The armature voltage is sensed by the voltage divider (adjustable) shown and then amplified and isolated by the 3650 .
The 3650 provides the advantage of accurate current measurement in the presence of high common-mode voltage. Both 3650s provide the advantage of isolating the motor ground from the control system ground. Isolated power is provided by an isolated DC/DC converter (BB Model 722 or equivalent).
The 3652 is ideally suited for patient monitoring applications as shown in Figure 9. The fact that it is a true balanced input instrumentation amplifier with very high differential and common-mode impedance means that it can greatly reduce the common-mode noise pick up due to imbalance in lead impedances that often appear in patient monitoring situations. The 3 kV and 6 kV shown in Figure 9 are the 10 ms pulse ratings of the $+I_{R}$ and $-I_{R}$ inputs for the common-mode and differential input voltages with respect to input common. The rating of the isolation barrier is 2000 Vpk continu-


FIGURE 8. Isolated Armature Current and Voltage Sensor.
ous. The nonrecurrent pulse rating of the isolation barrier is 5000 Vpk , since each unit is factory tested at 5000 Vpk . If the isolation barrier is to be subjected to higher voltages a gas filled surge voltage protection device can be used. For multichannel operation, two 3652 s can be powered by one

Model 722 isolated DC/DC converter. The total leakage current for both channels at 240 V 60 Hz would still be less than $2 \mu \mathrm{~A}$.
The block diagram in Figure 10 shows the use of isolation amplifiers in SCR control application.


FIGURE 9. 3652 Used in Patient Monitoring Application (ECG, VCG, EMG Amplifier).


FIGURE 10. 3-Phase Bidirectional SCR Control with Voltage Feedback.

## PACKAGING INFORMATION

| ORDERABLE DEVICE | STATUS(1) | PACKAGE TYPE | PACKAGE DRAWING | PINS | PACKAGE QTY |
| :---: | :---: | :---: | :---: | :---: | :---: |
| 3650 HG | NRND | CDIP | JNC | 32 | 1 |
| 3650 JG | NRND | CDIP | JNC | 32 | 10 |
| 3650 KG | NRND | CDIP | JNC | 32 | 10 |
| 3650 MG | NRND | CDIP | JNC | 32 | 10 |

(1) The marketing status values are defined as follows: ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
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